



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Krutchinsky, et al. Examiner: Paul M. Gurzo

Serial No.: 10/657,580 Group Art Unit: 2881

Filed: September 8, 2003 Docket: 1119-2 CON

Confirmation No.: 9872 Dated: May 24, 2004

For: METHOD OF TRANSMITTING

IONS FOR MASS SPECTROSCOPY

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

I hereby certify this correspondence is being deposited with the United States Postal Service as first class mail, postpaid in an envelope, addressed to:

Commissioner for Patents, P.O. Box 1450, Alexandria, VA 2313 on May 24, 2004

# SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

In order to fulfill the requirements of candor and good faith set forth in 37 C.F.R. § 1.56, Applicants submit a Supplemental Information Disclosure Statement in accordance with the provisions of 37 C.F.R. § 1.97 and § 1.98. This disclosure supplements the original Information Disclosure Statement filed on September 8, 2003.

## **UNITED STATES PATENTS**

PATENT NUMBER	ISSUE DATE	<u>PATENTEE</u>
5,811,800	September 22, 1998	Franzen et al.
6,417,511	July 9, 2002	Russ, IV et al.

## **NON-PATENT PUBLICATIONS**

B. Thomson, C. Jolliffe and R. Javahery, Proc. 44th ASMS Conf. on Mass 1. Spectrometry and Allied Topics, p. 1155 (1996).

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2. A.V. Tolmachev, et al., "A collisional focusing ion guide for coupling an atmospheric pressure ion source to a mass spectrometer", *Nuclear Instruments and Methods in Physics Research B* Vol. 124, pp. 112-119 (1997).

Applicants are in receipt of an Office Action dated February 23, 2004 and thus make the following certification as required under 37 C.F.R. § 1.97(c)(1).

### **CERTIFICATION**

In accordance with 37 C.F.R. § 1.97(e)(2), the undersigned attorney for the Applicants hereby certifies that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign Patent Office and a counterpart foreign application, and to the knowledge of the person signing this certification after making a reasonable inquiry, no item of information contained in the Information Disclosure Statement was known to any individual designated in § 1.56(c) more than three months prior to the filing of the Information Disclosure Statement.

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If the Examiner has any questions or comments relating to the present application, he or she is respectfully invited to contact Applicants' attorney at the phone number set forth below.

Respectfully submitted,

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FORM PTO-144	9 U.S. [	DEPARTME	NT OF COMME	RCE
(Rev. 2-32)	PATENT A	AND TRADI	EMARK OFFICE	<u>:</u>

ATTY. DOCKET NO.	SERIAL NO.		
1119-2 CON	10/657,580		
APPLICANT Krutchinsky, et al.	CONFIRMATION NO. 9872		

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

FILING DATE	GROUP
	2881

### U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	5,811,800	9/22/98	Franzen et al.			
	6,417,511	7/9/02	Russ, IV et al.			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

B. Thomson, C. Jolliffe and R. Javahery, Proc. 44<sup>th</sup> ASMS Conf. on Mass Spectrometry and Allied Topics, p. 1155 (1996).

A.V. Tolmachev, et al., "A collisional focusing ion guide for coupling an atmospheric pressure ion source to a mass spectrometer", Nuclear Instruments

and Methods in Physics Research B Vol. 124, pp. 112-119 (1997).

#### **EXAMINER**

#### DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication with applicant.